

14th European Workshop on Modern Developments and Applications in Microbeam Analysis (EMAS 2015 Workshop)

IOP Conference Series: Materials Science and Engineering
Volume 109

Portoroz, Slovenia
3 – 7 May 2015

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ISBN: 978-1-5108-2085-2
ISSN: 1757-8981

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Table of contents

Volume 109

14th European Workshop on Modern Developments and Applications in Microbeam Analysis (EMAS 2015 Workshop)
3–7 May 2015, Portorož, Slovenia

Accepted papers received: 22 December 2015

Published online: 9 February 2016

Preface

011001

[European Microbeam Analysis Society's 14th European Workshop on Modern Developments and Applications in Microbeam Analysis \(EMAS 2015\), Portorož, Slovenia, 3–7 May 2015](#) OPEN ACCESS X Llovet, M B Matthews, M Čeh, E Langer, K Žagar

011002

[Peer review statement](#) OPEN ACCESS

Papers

012001

[Measurements of the quantitative lateral analytical resolution at sputtered gold-layers with the FEG-EPMA JEOL JXA-8530F](#) OPEN ACCESS D Berger and J Nissen""r i 03

012002

[A complementary approach to estimate the internal pressure of fission gas bubbles by SEM-SIMS-EPMA in irradiated nuclear fuels](#) OPEN ACCESS C Cagna, I Zacharie-Aubrun, P Bienvenu, L Barrallier, B Michel and J Noirot""r i 035

012003

[Low voltage EPMA: experiments on a new frontier in microanalysis - analytical lateral resolution](#) OPEN ACCESS J Fournelle, H Cathey, P T Pinard and S Richter""r i 046

012004

[The role of intergranular chromium carbides on intergranular oxidation of nickel based alloys in pressurized water reactors primary water](#) OPEN ACCESS F O M Gaslain, H T Le, C Duhamel, C Guerre and P Laghoutaris""r i 059

012005

[Electron probe microanalysis of Ni-silicides at low voltage: difficulties and possibilities](#) OPEN ACCESS E. Heikinheimo, P.T. Pinard, S. Richter, X. Llovet and S. Louhenkilpi""r i 069

012006

[Characterisation of nanoparticles by means of high-resolution SEM/EDS in transmission mode](#) OPEN ACCESS V-D Hodoroaba, S Rades, T Salge, J Mielke, E Ortel and R Schmidt""r i 079

012007

[Fundamentals of electron energy-loss spectroscopy](#) OPEN ACCESS F Hofer, F P Schmidt, W Grogger and G Kothleitner""r i 08;

012008

[Quantitative ADF STEM: acquisition, analysis and interpretation](#) OPEN ACCESS L Jones""r i 09:

012009

[PENEPMA: a Monte Carlo programme for the simulation of X-ray emission in EPMA](#) OPEN ACCESS X Llovet and F Salvat""r i 0; :

012010

[SEM and FIB-SEM investigations on potential gas shales in the Dniepr-Donets Basin \(Ukraine\): pore space evolution in organic matter during thermal maturation](#) OPEN ACCESS D Misch, F Mendez-Martin, G Hawranek, P Onuk, D Gross and R F Sachsenhofer""r i 0333

012011

[Effect of shape and thickness of asbestos bundles and fibres on EDS microanalysis: A Monte Carlo simulation](#) OPEN ACCESS D Moro and G Valdre""r i 0346

012012

[Effects of cold rolling deformation on microstructure in 18/8 grade stainless steel](#) OPEN ACCESS A Núñez Galindo and J F Almagro Bello""r i 0357

012013

[Quantification of low concentration elements using soft X-rays at high spatial resolution](#) OPEN ACCESS P T Pinard and S Richter""r i 0368

012014

[Combined EPMA, FIB and Monte Carlo simulation: a versatile tool for quantitative analysis of multilayered structures](#) OPEN ACCESS S Richter and P T Pinard""r i 0377

012015

[Electron probe microanalysis of the dopant concentrations in complex perovskite ferroelectrics](#) OPEN ACCESS Z Samardžija""r i 038:

012016

[Improved spectrum simulation for validating SEM-EDS analysis](#) OPEN ACCESS P Statham, C Penman and P Duncumb""r i 039;

012017

[Development of soft X-ray emission spectrometer for EPMA/SEM and its application](#) OPEN ACCESS H Takahashi, T Murano, M Takakura, S Asahina, M Terauchi, M Koike, T Imazono, M Koeda and T Nagano""r i 03: ;

012018

[Physics-based simulation models for EBSD: advances and challenges](#) OPEN ACCESS A Winkelmann, G Nolze, M Vos, F Salvat-Pujol and W S M Werner""r i 0422

012019

[Low voltage imaging and X-ray microanalysis in the SEM: challenges and opportunities](#) OPEN ACCESS R Wuhrer and K Moran""r i 0435

012020

[Pyrite-pyrrhotite intergrowths in calcite marble from Bistriški Vintgar, Slovenia](#) OPEN ACCESS J Zavašnik""r i 0449